## Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10618154	REICHARDT ET AL.
Examiner	Art Unit
Hoang-Vu A Nguyen-Ba	2623

SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES				
Search Notes	Date	Examiner		
725/33-44, 112, 135-136, 139-140, 51, 61 text search only	3/5/08	HAN		
Son Huynh consulted	3/5/08	HAN		

INTERFERENCE SEARCH				
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